Power MOSFET

-20 V, -3.16 A, Single P-Channel TSOP-6

Features

- Ultra Low R_{DS(on)} to Improve Conduction Loss
- Low Gate Charge to Improve Switching Losses
- TSOP-6 Surface Mount Package
- This is a Pb–Free Device

Applications

- High Side Switch in DC–DC Converters
- Battery Management

MAXIMUM RATINGS (T_J = 25° C unless otherwise stated)

Parameter			Symbol	Value	Unit
Drain-to-Source Voltage			V _{DSS}	-20	V
Gate-to-Source Voltage			V _{GS}	±12	V
Continuous Drain	Steady	$T_A = 25^{\circ}C$	I _D	-2.5	А
Current (Note 1)	State	$T_A = 85^{\circ}C$		-1.8	
	t = 10 s	$T_A = 25^{\circ}C$		-3.16	
Power Dissipation (Note 1)	Steady State	$T_A = 25^{\circ}C$	P _D	0.98	W
	t = 10 s			1.60	
Continuous Drain	Steady	$T_A = 25^{\circ}C$	I _D	-1.8	А
Current (Note 2)	State	$T_A = 85^{\circ}C$		-1.3	
Power Dissipation (Note 2)		$T_A = 25^{\circ}C$	P _D	0.51	W
Pulsed Drain Current	t _p = 10 μs		I _{DM}	-13	А
Operating Junction and Storage Temperature			T _J , T _{STG}	–55 to 150	°C
Source Current (Body Diode)			۱ _S	-1.5	А
Lead Temperature for Soldering Purposes (1/8" from case for 10 s)			ΤL	260	°C

Maximum ratings are those values beyond which device damage can occur. Maximum ratings applied to the device are individual stress limit values (not normal operating conditions) and are not valid simultaneously. If these limits are exceeded, device functional operation is not implied, damage may occur and reliability may be affected.

- 1. Surface-mounted on FR4 board using 1 in sq pad size (Cu area = 1.127 in sq [1 oz] including traces)
- Surface-mounted on FR4 board using the minimum recommended pad size (Cu area = 0.0751 in sq)

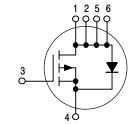


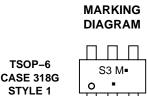
ON Semiconductor®

http://onsemi.com

V _{(BR)DSS}	(BR)DSS RDS(ON) TYP	
	91 mΩ @ 4.5 V	
–20 V	144 mΩ @ 2.7 V	–3.16 A
	188 mΩ @ 2.5 V	







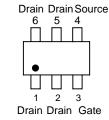




= Pb–Free Package

(Note: Microdot may be in either location)

PIN ASSIGNMENT



ORDERING INFORMATION

Device	Package	Shipping [†]
NTGS3441P	TSOP-6 (Pb-Free)	3000 / Tape & Reel

+For information on tape and reel specifications, including part orientation and tape sizes, please refer to our Tape and Reel Packaging Specifications Brochure, BRD8011/D.

THERMAL RESISTANCE MAXIMUM RATINGS

Parameter	Symbol	Value	Unit
Junction-to-Ambient - Steady State (Note 3)	$R_{ hetaJA}$	128	°C/W
Junction-to-Ambient - t = 10 s (Note 3)	$R_{ hetaJA}$	78	
Junction-to-Ambient - Steady State (Note 4)	$R_{ hetaJA}$	244	

Surface-mounted on FR4 board using 1 in sq pad size (Cu area = 1.127 in sq [1 oz] including traces)
 Surface-mounted on FR4 board using the minimum recommended pad size (Cu area = TBD in sq)

FLECTRICAL CHARACTERISTICS (T) - 25°C uplace otherwise specified)

Parameter	Symbol	Test Condition		Min	Тур	Max	Unit
OFF CHARACTERISTICS	•	•					
Drain-to-Source Breakdown Voltage	V _{(BR)DSS}	V_{GS} = 0 V, I _D =	= –250 μA	-20			V
Drain-to-Source Breakdown Voltage Temperature Coefficient	V _{(BR)DSS} /T _J				16		mV/ °C
Zero Gate Voltage Drain Current	I _{DSS}	V _{GS} = 0 V, V _{DS} = -20 V	T _J = 25°C T _J = 125°C			-1 -10	μΑ
Gate-to-Source Leakage Current	I _{GSS}	V _{DS} = 0 V, V _{GS}	ÿ			±100	nA
ON CHARACTERISTICS (Note 5)			-				
Gate Threshold Voltage	V _{GS(TH)}	$V_{GS} = V_{DS}, I_{D} =$	= –250 μA	0.6		1.6	V
Negative Threshold Temperature Coefficient	V _{GS(TH)} /T _J				3.2		mV/°C
Drain-to-Source On Resistance	R _{DS(on)}	V _{GS} = 4.5 V, I _D	₀ = -3.0 A		91	110	mΩ
	. ,	V _{GS} = 2.7 V, I _D	₀ = -1.5 A		144	165	
		V _{GS} = 2.5 V, I _D	₀ = -1.5 A		188		1
Forward Transconductance	9 _{FS}	V _{DS} = -15 V, I _I	_D =–1.5 A		4.0		S
CHARGES, CAPACITANCES AND GATE RES	ISTANCE	•					
Input Capacitance	C _{ISS}				345		pF
Output Capacitance	C _{OSS}	$V_{GS} = 0 V$, f = 1 MHz, $V_{DS} = -15 V$			150		1
Reverse Transfer Capacitance	C _{RSS}				40		
Total Gate Charge	Q _{G(TOT)}	V _{GS} = 4.5 V, V _{DS} = -10 V; I _D = -3.0 A			3.25	6.0	nC
Threshold Gate Charge	Q _{G(TH)}				0.3		-
Gate-to-Source Charge	Q_{GS}				0.6		
Gate-to-Drain Charge	Q_{GD}				1.4		1
SWITCHING CHARACTERISTICS (Note 6)							
Turn-On Delay Time	t _{d(ON)}				7.0	12	ns
Rise Time	Tr	V_{GS} = 4.5 V, V_{D}			14	25]
Turn–Off Delay Time	t _{d(OFF)}	$I_{\rm D} = -1.5 \text{ A}, \text{ R}_{\rm G} = 4.7 \Omega$			13	25]
Fall Time	Τ _f				4.0	8.0	
DRAIN-SOURCE DIODE CHARACTERISTICS	6						
Forward Diode Voltage	V _{SD}	$V_{GS} = 0 V,$	$T_J = 25^{\circ}C$		0.8	1.2	V
		$I_{\rm S} = -3.0 \text{A}$ $T_{\rm J} = 125^{\circ}\text{C}$			0.7		
Reverse Recovery Time	t _{RR}	V_{GS} = 0 V, d _{IS} /d _t = 100 A/µs, I _S = -3.0 A			25		ns
Charge Time	Ta				10		1
Discharge Time	Tb				15		1
		1				1	

5. Switching characteristics are independent of operating junction temperatures

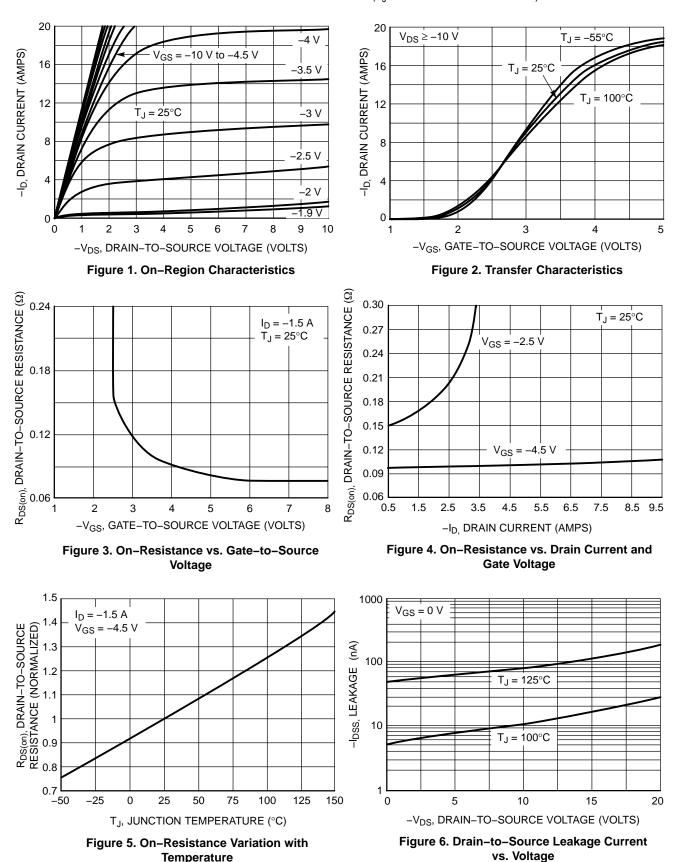
6. Pulse Test: pulse width = 300 μ s, duty cycle = 2%

Reverse Recovery Charge

15

nC

Q_{RR}



TYPICAL PERFORMANCE CURVES (T_J = 25° C unless otherwise noted)

Temperature

TYPICAL PERFORMANCE CURVES (T_J = 25°C unless otherwise noted)

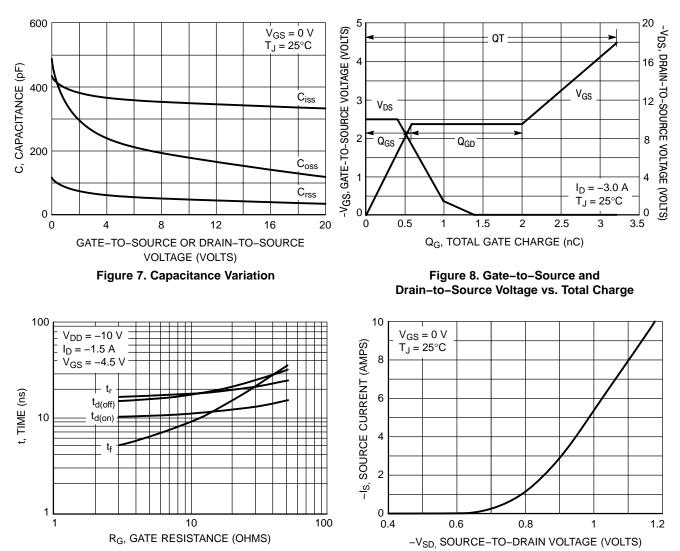
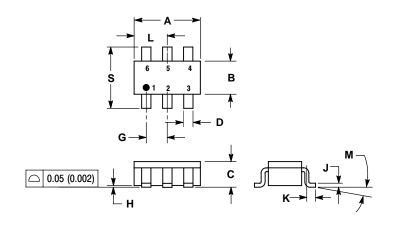


Figure 9. Gate Threshold Voltage Variation with Temperature

Figure 10. Diode Forward Voltage vs. Current

PACKAGE DIMENSIONS

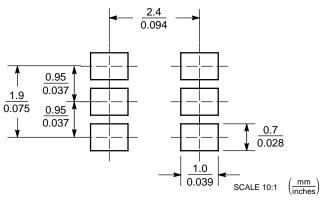
TSOP-6 CASE 318G-02 **ISSUE N**



NOTES:
1. DIMENSIONING AND TOLERANCING PER ANSI Y14.5M, 1982.
2. CONTROLLING DIMENSION: MILLIMETER.
3. MAXIMUM LEAD THICKNESS INCLUDES LEAD FINISH THICKNESS. MINIMUM LEAD THICKNESS IS THE MINIMUM THICKNESS OF BASE MATERIAL.
4. DIMENSIONS A AND B DO NOT INCLUDE MOLD FLASH, PROTRUSIONS, OR GATE BURRS.

	MILLIN	IETERS	INCHES			
DIM	MIN MAX		MIN	MAX		
Α	2.90	3.10	0.1142	0.1220		
В	1.30	1.70	0.0512	0.0669		
С	0.90	1.10	0.0354	0.0433		
D	0.25	0.50	0.0098	0.0197		
G	0.85	1.05	0.0335	0.0413		
Н	0.013	0.100	0.0005	0.0040		
J	0.10	0.26	0.0040	0.0102		
Κ	0.20	0.60	0.0079	0.0236		
L	1.25	1.55	0.0493	0.0610		
Μ	0 °	10 °	0 °	10 °		
S	2.50	3.00	0.0985	0.1181		
STYLE 1: PIN 1. DRAIN 2. DRAIN 3. GATE 4. SOURCE 5. DRAIN 6. DRAIN						

SOLDERING FOOTPRINT*



*For additional information on our Pb-Free strategy and soldering details, please download the ON Semiconductor Soldering and Mounting Techniques Reference Manual, SOLDERRM/D.

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